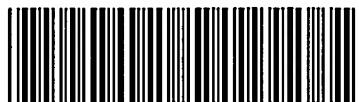


**Search Notes****Application/Control No.**

10/630,983

**Examiner**

Hai L. Nguyen

**Applicant(s)/Patent under Reexamination**

KOIKE, HIDEHARU

**Art Unit**

2816

**SEARCHED**

Class	Subclass	Date	Examiner
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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Shepardize Search, see search history printout	10/31/2005	HLN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
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